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APPLICATION NO.	F	TILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/620,968		07/20/2000	Shunpei Yamazaki	0756-2183	4214
22204	7590	04/28/2006		EXAMINER	
NIXON PE				HA, NATHAN W	
401 9TH STREET, NW SUITE 900 WASHINGTON, DC 20004-2128				ART UNIT	PAPER NUMBER
				2814	
				DATE MAILED: 04/28/200	DATE MAILED: 04/28/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)				
	09/620,968	YAMAZAKI, SHUNPEI				
Office Action Summary	Examiner	Art Unit				
	Nathan W. Ha	2814				
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address				
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  If NO period for reply is specified above, the maximum statutory period w Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim vill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONEI	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).				
Status						
<ul> <li>1) ⊠ Responsive to communication(s) filed on 28 Fe</li> <li>2a) ☐ This action is FINAL.</li> <li>2b) ☒ This</li> <li>3) ☐ Since this application is in condition for allowar closed in accordance with the practice under E</li> </ul>	action is non-final. nce except for formal matters, pro					
Disposition of Claims						
4) □ Claim(s) 2-31 is/are pending in the application. 4a) Of the above claim(s) is/are withdraw 5) □ Claim(s) is/are allowed. 6) □ Claim(s) 2-31 is/are rejected. 7) □ Claim(s) is/are objected to. 8) □ Claim(s) are subject to restriction and/o  Application Papers  9) □ The specification is objected to by the Examine 10) □ The drawing(s) filed on is/are: a) □ accomplicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) □ The oath or declaration is objected to by the Examine	vn from consideration.  r election requirement.  r.  epted or b) □ objected to by the B drawing(s) be held in abeyance. See ion is required if the drawing(s) is obj	e 37 CFR 1.85(a). jected to. See 37 CFR 1.121(d).				
Priority under 35 U.S.C. § 119						
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No.</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>						
Attachment(s)  1) ☑ Notice of References Cited (PTO-892)  2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)  3) ☑ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date 9/02.	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:					

Application/Control Number: 09/620,968

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### **DETAILED ACTION**

## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 2-3, 5-6, 9-10, 12-13, 16, and 19-20, and 26-31 are rejected under 35 U.S.C. 103(a) as being unpatentable over Inoue (US 4,976,839, newly cited).

In regard to claims 2, 5, 9, 12, 16, and 19, in figs. 3-7, Inoue discloses a method for manufacturing a semiconductor device comprising the steps of:

forming an insulating film 12 of silicon nitride over a semiconductor substrate 11 by sputtering in a chamber with an atmosphere comprising gases including nitrogen of 50-75% of the gases. See col. 6, lines 15-50 and claim 4.

It appears that the Inoue teaches the range of the nitrogen volume is 50-75%, with touches the range as claimed, 75%. But this range may be modify in the chamber in order to adjust the total volume of the gases in the room depending on the layer's property that need to meet the requirements and to improve a certain device's characteristic.

Therefore, it would have been obvious to one of ordinary skill in the art at the time of the invention was made to realize that the modification of the volume of the nitrogen is obvious in order to adjust the layer and the chamber's condition.

The electrode is made of aluminum. See col. 6, lines 50-51.

In regard to claims 26-31, as mentioned, the targeting layer is silicon nitride layer.

- 3. In regard to claims 3, 6, 10, 13, 17, and 20 the sputtering is RF sputtering, or plasma. See fig. 1 and col. 6, lines 46-50.
- 4. Claims 4, 7, 11, 14, 18 and 21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Inoue as applied to claims 2-3, 5-6, 10, 12-13, 16, and 20 above, and further in view of Nomoto et al. (US 5,225,364, previously cited, hereinafter Nomoto.)

In regard to claims 4, 7, 11, 14, 18 and 21 Inoue discloses all of the claimed limitations as mentioned above and mentions the applications of thin films of refractory metal nitride (see the front fact of the patent) except expressly teaches the device can be used in a matrix display. It is noted that the device of Cunningham in fact can be used in a matrix display device since it is a metallization device. It is used to carry out signal or power connection. However, in order to show the obviousness of this utility, Nomoto is incorporated herein. Nomoto discloses an analogous semiconductor device with substrate 1, silicon nitride insulating layer 5 and an aluminum electrode 8. The matrix has plurality devices that connect in rows and columns. Therefore, it is proper to combine this structure to a metallization structure in order to carry out the intended product, or design choice of a product.

Therefore, it would have been obvious to one of ordinary skill in the art at the time of the invention was made to adapt matrix device as taught by Nomoto in Inoue's in order to carry out the advantage mentioned above.

5. Claims 8, 15, and 22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Inoue as applied to claims 2-3, 5-6, 10, 12-13, 16, and 20 above, and further in view of Yamazaki et al. (US 6,586,346, previously cited, herein, Yamazaki.)

In regard to claims 8, 15, and 22-25, the above combination discloses all of the claimed limitations except the volumes of argon and halogen, fluorine, see the abstract. Yamazaki discloses an analogous process and further includes the volumes of the argon and halogen as claimed in claims 5, 8, 15, and 22 in order to prevent fixed electric charges from being generated in the film (see the abstract.)

Therefore, it would have been obvious to one of ordinary skill in the art at the time of the invention was made to use appropriate volumes of the argon and halogen materials in order to prevent fixed electric charges from being generated in the film.

## Response to Arguments

6. Applicant's arguments with respect to claims 2-22 have been considered but are most in view of the new ground(s) of rejection.

#### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Nathan W. Ha whose telephone number is (571) 272-1707. The examiner can normally be reached on M-TH 8:00-7:00(EST).

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wael Fahmy can be reached on (571) 272-1705. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Nathan Ha

April 26, 2006